

Notice of References Cited

Application/Control No.

09/842,317

Applicant(s)/Patent Under
Reexamination
BOUDREAU ET AL.

Examiner

David G. Cervetti

Art Unit

2136

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,185,684 B1	02-2001	Pravetz et al.	713/182
*	B	US-6,240,516 B1	05-2001	Vainsencher, Leonardo	713/190
*	C	US-2001/0042043 A1	11-2001	SHEAR et al.	705/51
*	D	US-2002/0073336 A1	06-2002	Toy et al.	713/201
*	E	US-2002/0103734 A1	08-2002	Glassco et al.	705/35
*	F	US-6,457,130 B2	09-2002	Hitz et al.	726/27
*	G	US-6,477,653 B2	11-2002	Naito, Kazunori	726/27
*	H	US-6,490,686 B1	12-2002	Wheeler, Peter	726/27
*	I	US-2004/0107356 A1	06-2004	Shamoon et al.	713/193
*	J	US-7,096,504 B1	08-2006	Tagawa et al.	726/27
*	K	US-7,124,443 B2	10-2006	Ishibashi et al.	726/26
*	L	US-7,155,745 B1	12-2006	Shin et al.	726/27
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.